

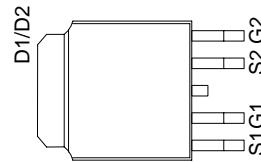
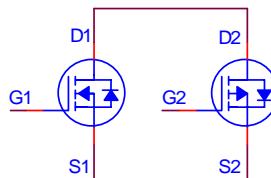
NIKO-SEM
**N- & P-Channel Enhancement Mode
Field Effect Transistor _ Preliminary**
P2804ND5G

TO-252-5

Lead-Free

PRODUCT SUMMARY

	$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
N-Channel	40	28m	7A
P-Channel	-40	55m	-5.5A


 G : GATE
 D : DRAIN
 S : SOURCE
ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS	SYMBOL	N-Channel	P-Channel	UNITS
Drain-Source Voltage	V_{DS}	40	-40	V
Gate-Source Voltage	V_{GS}	± 20	± 20	V
Continuous Drain Current	I_D	7	-5.5	A
		6	-4.5	
Pulsed Drain Current ¹	I_{DM}	50	-50	
Power Dissipation	P_D		3	W
			2.1	
Junction & Storage Temperature Range	T_j, T_{stg}	-55 to 150		°C
Lead Temperature ($1/16$ " from case for 10 sec.)	T_L	275		

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Case	$R_{\theta JC}$		6	°C / W
Junction-to-Ambient	$R_{\theta JA}$		42	°C / W

¹Pulse width limited by maximum junction temperature.²Duty cycle $\leq 1\%$ **ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$, Unless Otherwise Noted)**

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu\text{A}$	N-Ch	40		
		$V_{GS} = 0V, I_D = -250\mu\text{A}$	P-Ch	-40		
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	N-Ch	1.0	1.5	2.5
		$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$	P-Ch	-1.0	-1.5	-2.5
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0V, V_{GS} = \pm 20V$	N-Ch			± 100
		$V_{DS} = 0V, V_{GS} = \pm 20V$	P-Ch			± 100 nA

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Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 32V, V_{GS} = 0V$	N-Ch			1	μA
		$V_{DS} = -32V, V_{GS} = 0V$	P-Ch			-1	
		$V_{DS} = 30V, V_{GS} = 0V, T_J = 55 ^\circ C$	N-Ch			10	
		$V_{DS} = -30V, V_{GS} = 0V, T_J = 55 ^\circ C$	P-Ch			-10	
On-State Drain Current ¹	$I_{D(ON)}$	$V_{DS} = 5V, V_{GS} = 10V$	N-Ch	50			A
		$V_{DS} = -5V, V_{GS} = -10V$	P-Ch	-50			
Drain-Source Resistance ¹	On-State	$V_{GS} = 4.5V, I_D = 6A$	N-Ch		30	42	m
		$V_{GS} = -4.5V, I_D = -4.5A$	P-Ch		65	94	
		$V_{GS} = 10V, I_D = 7A$	N-Ch		21	28	
		$V_{GS} = -10V, I_D = -5.5A$	P-Ch		38	55	
Forward Transconductance ¹	g_{fs}	$V_{DS} = 10V, I_D = 7A$	N-Ch		19		S
		$V_{DS} = -10V, I_D = -5.5A$	P-Ch		11		

DYNAMIC

Input Capacitance	C_{iss}	N-Channel $V_{GS} = 0V, V_{DS} = 10V, f = 1MHz$ P-Channel $V_{GS} = 0V, V_{DS} = -10V, f = 1MHz$	N-Ch		790	988	pF
Output Capacitance	C_{oss}		P-Ch		690	863	
Reverse Transfer Capacitance	C_{rss}		N-Ch		175	245	
Reverse Transfer Capacitance	C_{rss}		P-Ch		310	430	
Total Gate Charge ²	Q_g	N-Channel $V_{DS} = 0.5V_{(BR)DSS}, V_{GS} = 10V,$ $I_D = 7A$ P-Channel $V_{DS} = 0.5V_{(BR)DSS}, V_{GS} = -10V,$ $I_D = -5.5A$	N-Ch		65	98	nC
Gate-Source Charge ²	Q_{gs}		P-Ch		75	113	
Gate-Drain Charge ²	Q_{gd}		N-Ch		16		
Gate-Drain Charge ²	Q_{gd}		P-Ch		14		

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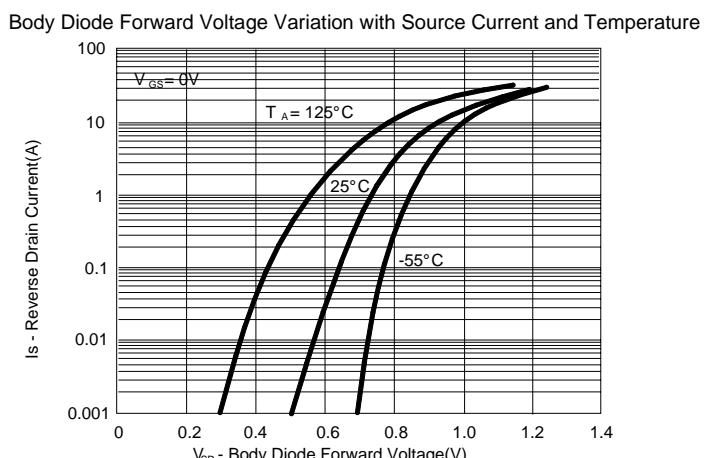
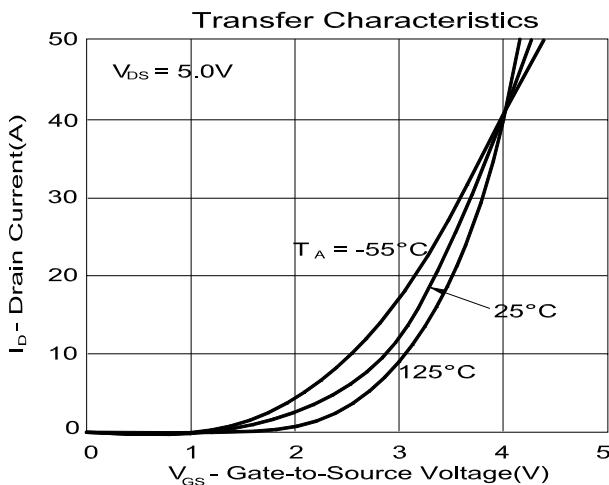
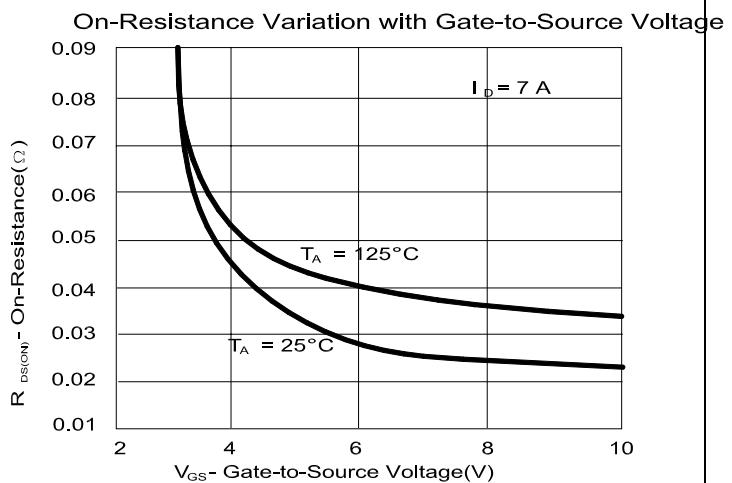
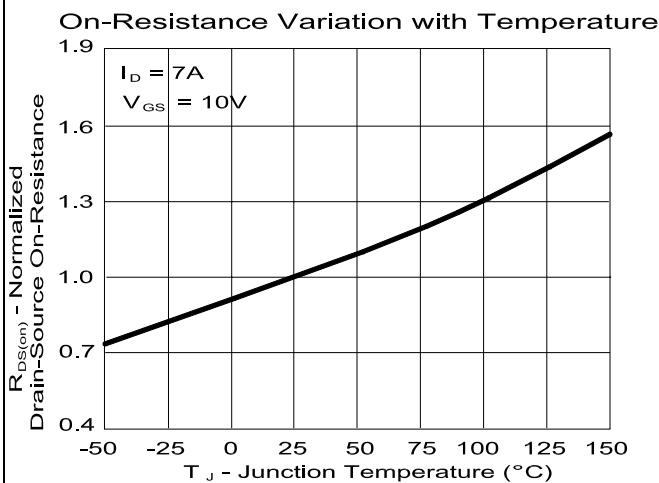
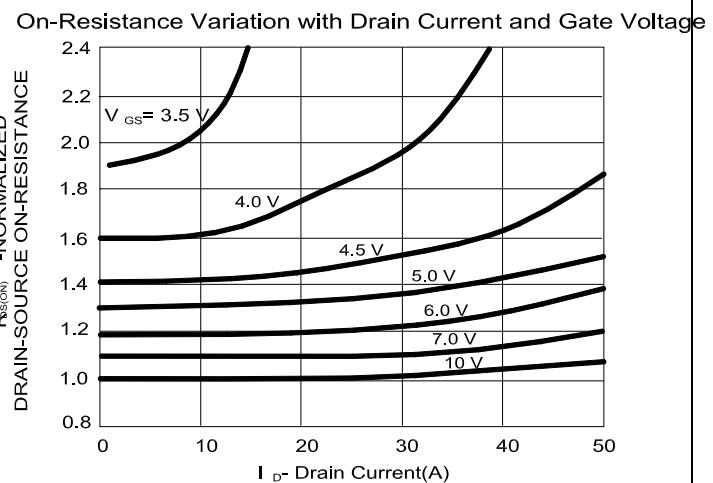
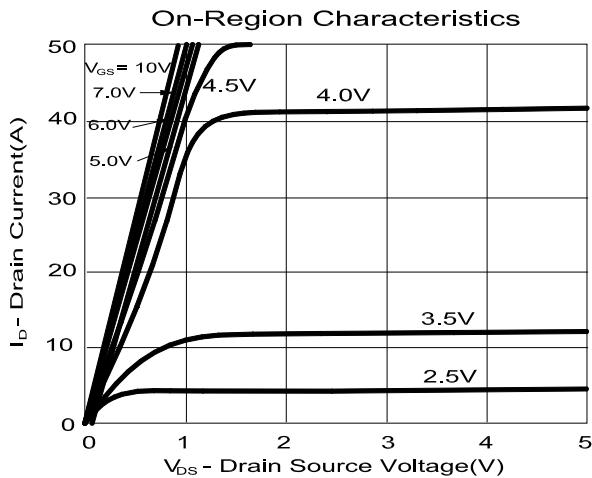
TO-252-5

Lead-Free

Turn-On Delay Time ²	$t_{d(on)}$	N-Channel $V_{DS} = 20V$ $I_D \geq 1A, V_{GS} = 10V, R_{GEN} = 6$ P-Channel $V_{DS} = -20V$ $I_D \leq -1A, V_{GS} = -10V, R_{GEN} = 6$	N-Ch	2.2	4.4	nS
Rise Time ²	t_r		P-Ch	6.7	13.4	
Turn-Off Delay Time ²	$t_{d(off)}$		N-Ch	7.5	15	
Fall Time ²	t_f		P-Ch	9.7	19.4	
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_C = 25^\circ C$)						
Forward Voltage ¹	V_{SD}	$I_F = 7A, V_{GS} = 0V$	N-Ch			1.2
		$I_F = -5.5A, V_{GS} = 0V$	P-Ch			-1.2
Reverse Recovery Time	t_{rr}	$I_F = 8A, dI_F/dt = 100A / \mu S$	N-Ch	42		nS
		$I_F = -7A, dI_F/dt = 100A / \mu S$	P-Ch	55		
Reverse Recovery Charge	Q_{rr}		N-Ch	30		nC
			P-Ch	52		

¹Pulse test : Pulse Width $\leq 300 \mu sec$, Duty Cycle $\leq 2\%$.²Independent of operating temperature.³Pulse width limited by maximum junction temperature.**REMARK: THE PRODUCT MARKED WITH "P2804ND5G", DATE CODE or LOT #**

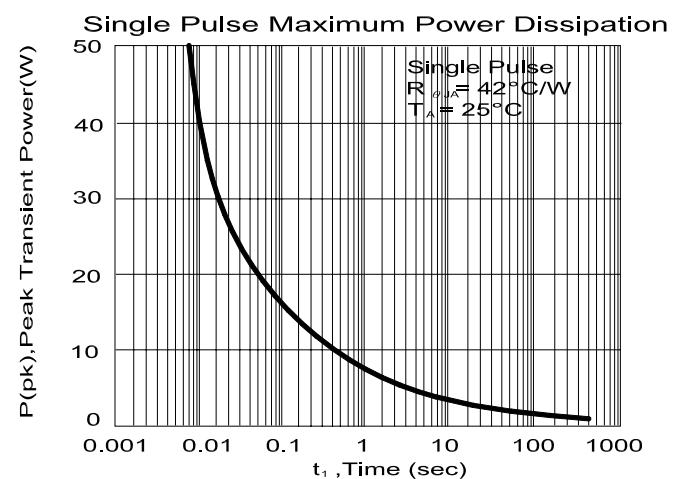
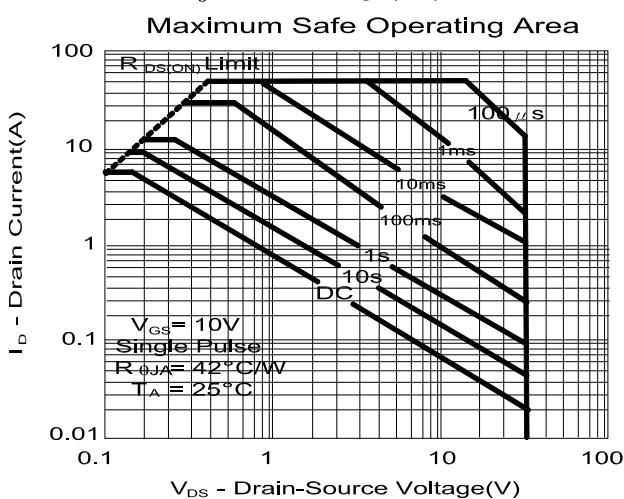
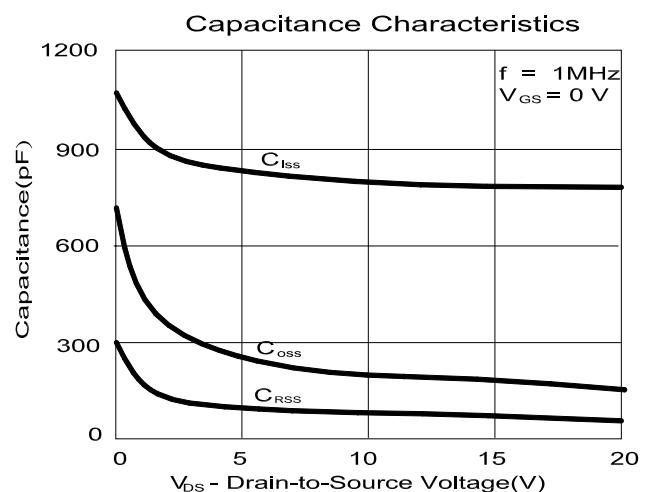
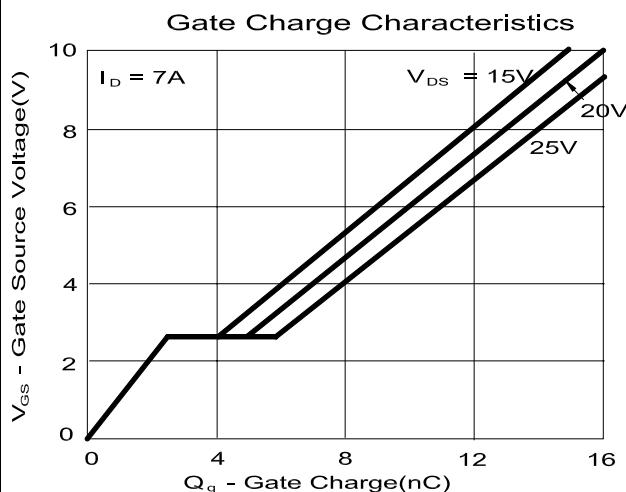
Orders for parts with Lead-Free plating can be placed using the PXXXXXXG parts name.

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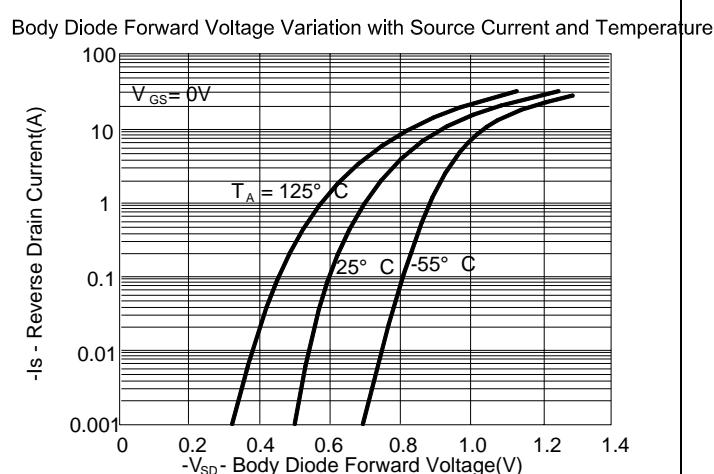
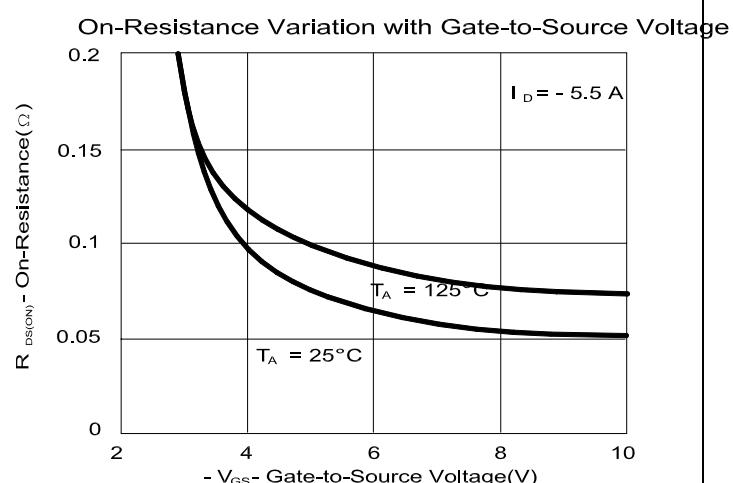
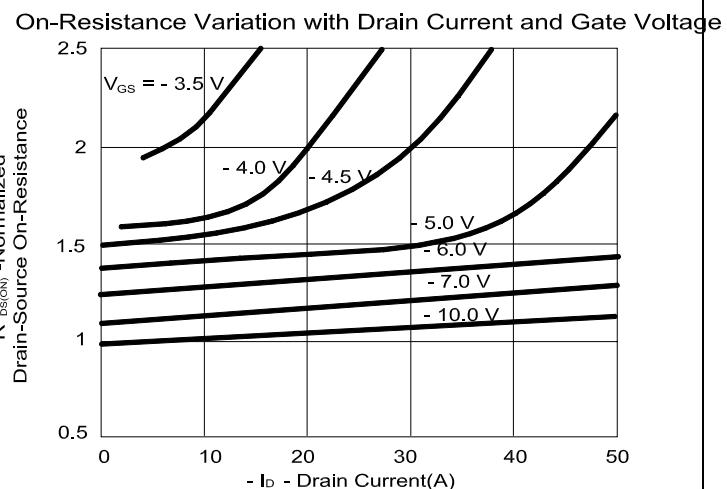
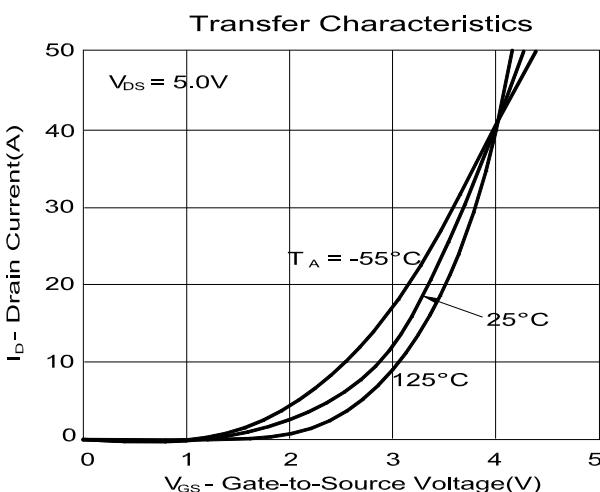
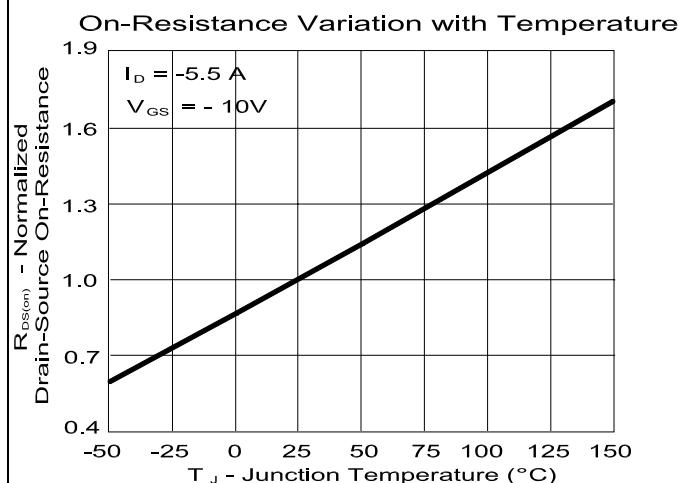
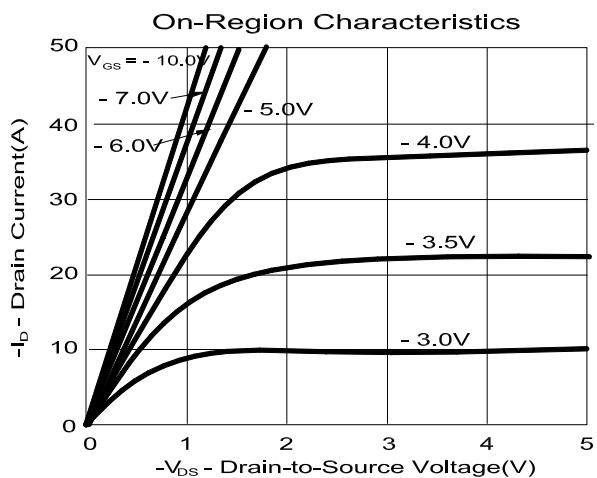
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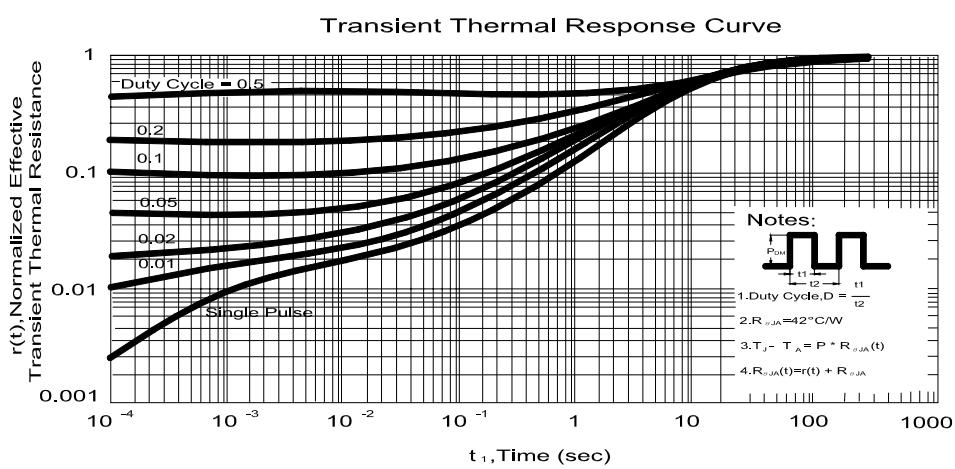
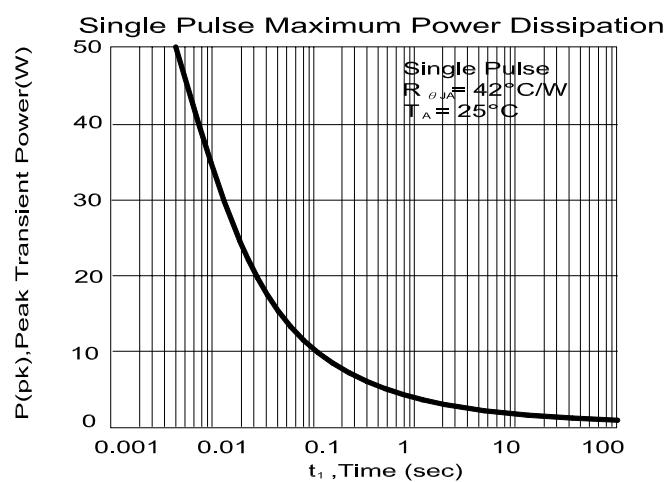
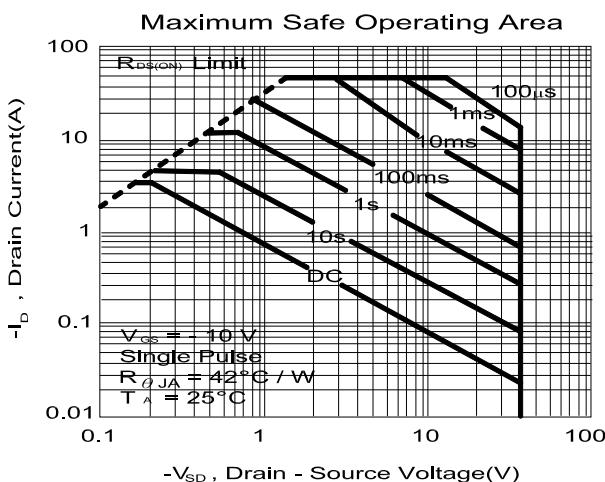
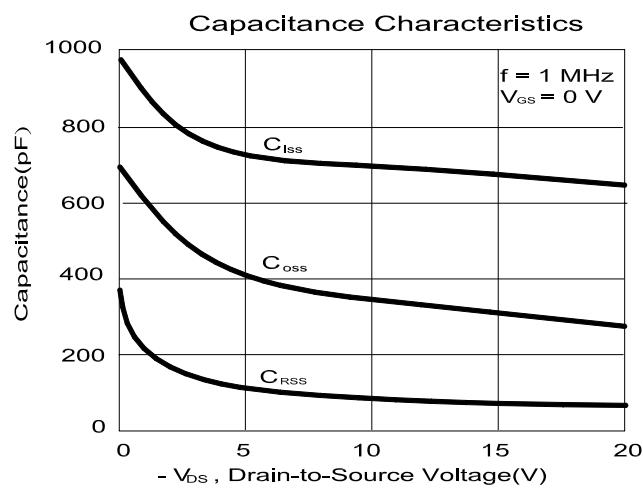
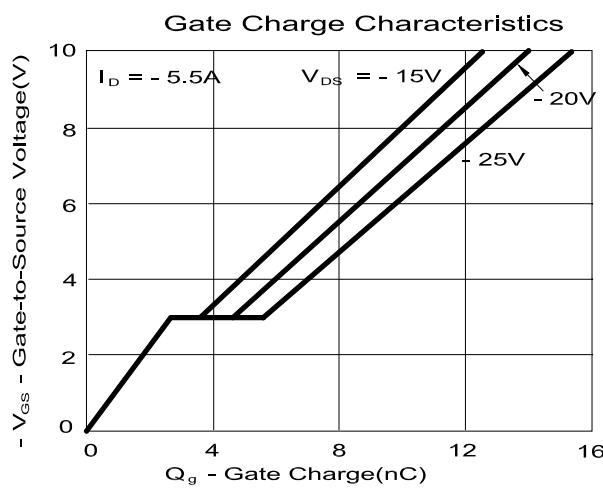


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TO-252-5 (DPAK) MECHANICAL DATA

Dimension	mm			Dimension	mm		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A	9.0	9.5	10.0	H	1.3	1.5	1.7
B	2.1	2.3	2.5	I	6.3	6.5	6.7
C	0.4	0.5	0.6	J	4.8	5.0	5.2
D	1.1	1.2	1.3	K	0.8	1.3	1.8
E	0.4	0.5	0.6	L	0.3	0.5	0.7
F	0.00		0.3	M	1.1	1.3	1.5
G	5.3	5.5	5.7	N			

